Document Number: MRF8P20100H
Rev. 0, 4/2010

RoHS

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

MRF8P20100HR3
MRF8P20100HSR3

1805-2025 MHz, 20 W AVG., 28 V
SINGLE W-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs

Designed for CDMA base station applications with frequencies from 1880 to 2025 MHz and GSM EDGE base station applications with frequencies from 1805 to 1880 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Doherty Single-Carrier W-CDMA Performance: V_{DD} = 28 Volts, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
2025 MHz	16.0	44.3	7.8	-33.5

1880 MHz

- Typical Doherty Single-Carrier W-CDMA Performance: V_{DD} = 28 Volts, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
1880 MHz	16.2	43.5	7.6	-30.8
1900 MHz	16.1	43.4	7.6	-32.6
1920 MHz	15.8	42.9	7.6	-34.6

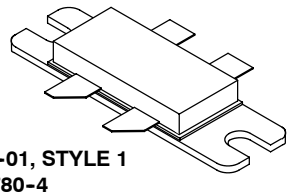
GSM EDGE

- Typical GSM EDGE Performance: V_{DD} = 28 Volts, I_{DQA} = I_{DQB} = 330 mA, P_{out} = 42 Watts Avg.

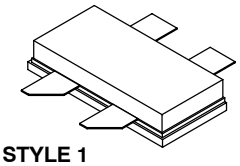
Frequency	G_{ps} (dB)	η_D (%)	SR1 @ 400 kHz (dBc)	SR2 @ 600 kHz (dBc)	EVM (% rms)
1805 MHz	17.1	43.8	-58.4	-74.4	3.0
1840 MHz	17.3	42.4	-60.0	-75.5	2.6
1880 MHz	17.1	41.7	-60.5	-75.3	2.4

Features

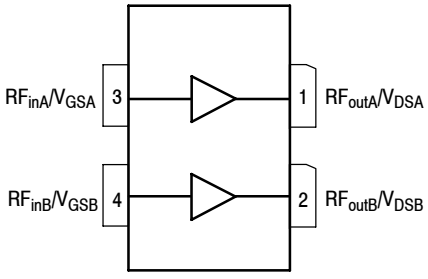
- Production Tested in a Symmetrical Doherty Configuration
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.



CASE 465M-01, STYLE 1
NI-780-4
MRF8P20100HR3



CASE 465H-02, STYLE 1
NI-780S-4
MRF8P20100HSR3



(Top View)

Figure 1. Pin Connections

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freescale semiconductor

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature (1,2)	T_J	225	°C
EDGE Operation @ T_C = 25°C (1) Derate above 25°C	EDGE	120 0.6	W (PEP) W (PEP)/°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 74°C, 20 W CW, 2025 MHz 28 Vdc, I_{DQA} = 400 mA 28 Vdc, V_{GSB} = 1.3 Vdc Case Temperature 80°C, 42 W CW, 1805 MHz 28 Vdc, I_{DQA} = I_{DQB} = 330 mA	$R_{\theta JC}$	 0.88 0.88 0.59	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Off Characteristics (4)					
Zero Gate Voltage Drain Leakage Current (V_{DS} = 65 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V_{DS} = 28 Vdc, V_{GS} = 0 Vdc)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current (V_{GS} = 5 Vdc, V_{DS} = 0 Vdc)	I_{GSS}	—	—	1	μAdc
On Characteristics (4)					
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 75 μAdc)	$V_{GS(th)}$	1.2	1.9	2.7	Vdc
Gate Quiescent Voltage (V_{DD} = 28 Vdc, I_{DA} = 400 mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.0	2.7	3.5	Vdc
Drain-Source On-Voltage (V_{GS} = 10 Vdc, I_D = 1 Adc)	$V_{DS(on)}$	0.1	0.2	0.3	Vdc

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers.* Go to http://www.freescale.com/rf. Select Documentation/Application Notes - AN1955.
4. Each side of device measured separately.

(continued)

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Functional Tests (1,2) (In Freescale Doherty Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg., f = 2025 MHz, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.					
Power Gain	G_{ps}	15.0	16.0	18.0	dB
Drain Efficiency	η_D	42.0	44.3	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	7.2	7.8	—	dB
Adjacent Channel Power Ratio	ACPR	—	-33.5	-31.0	dBc
Typical Performance (2) (In Freescale Doherty Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, 2010-2025 MHz Bandwidth					
P_{out} @ 1 dB Compression Point, CW	P1dB	—	78	—	W
P_{out} @ 3 dB Compression Point, CW	P3dB	—	126	—	W
IMD Symmetry @ 20 W PEP, P_{out} where IMD Third Order Intermodulation ≅ 30 dBc (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands > 2 dB)	IMD_{sym}	—	46	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW_{res}	—	53	—	MHz
Gain Flatness in 15 MHz Bandwidth @ P_{out} = 20 W Avg.	G_F	—	0.1	—	dB
Gain Variation over Temperature (-30°C to +85°C)	ΔG	—	0.013	—	dB/°C
Output Power Variation over Temperature (-30°C to +85°C)	ΔP1dB	—	0.004	—	dBm/°C

Typical Broadband Performance — 1880 MHz (2) (In Freescale 1880 MHz Doherty Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg., Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
1880 MHz	16.2	43.5	7.6	-30.8
1900 MHz	16.1	43.4	7.6	-32.6
1920 MHz	15.8	42.9	7.6	-34.6

Typical GSM EDGE Performance (3) (In Freescale Class AB Test Fixture, 50 ohm system) V_{DD} = 28 Volts, I_{DQA} = I_{DQB} = 330 mA, P_{out} = 42 Watts Avg., 1805-1880 MHz EDGE Modulation

Frequency	G_{ps} (dB)	η_D (%)	SR1 @ 400 kHz (dBc)	SR2 @ 600 kHz (dBc)	EVM (% rms)
1805 MHz	17.1	43.8	-58.4	-74.4	3.0
1840 MHz	17.3	42.4	-60.0	-75.5	2.6
1880 MHz	17.1	41.7	-60.5	-75.3	2.4

1. Part internally matched both on input and output.
2. Measurement made with device in a Symmetrical Doherty configuration.
3. Measurement made with device in quadrature combined configuration.

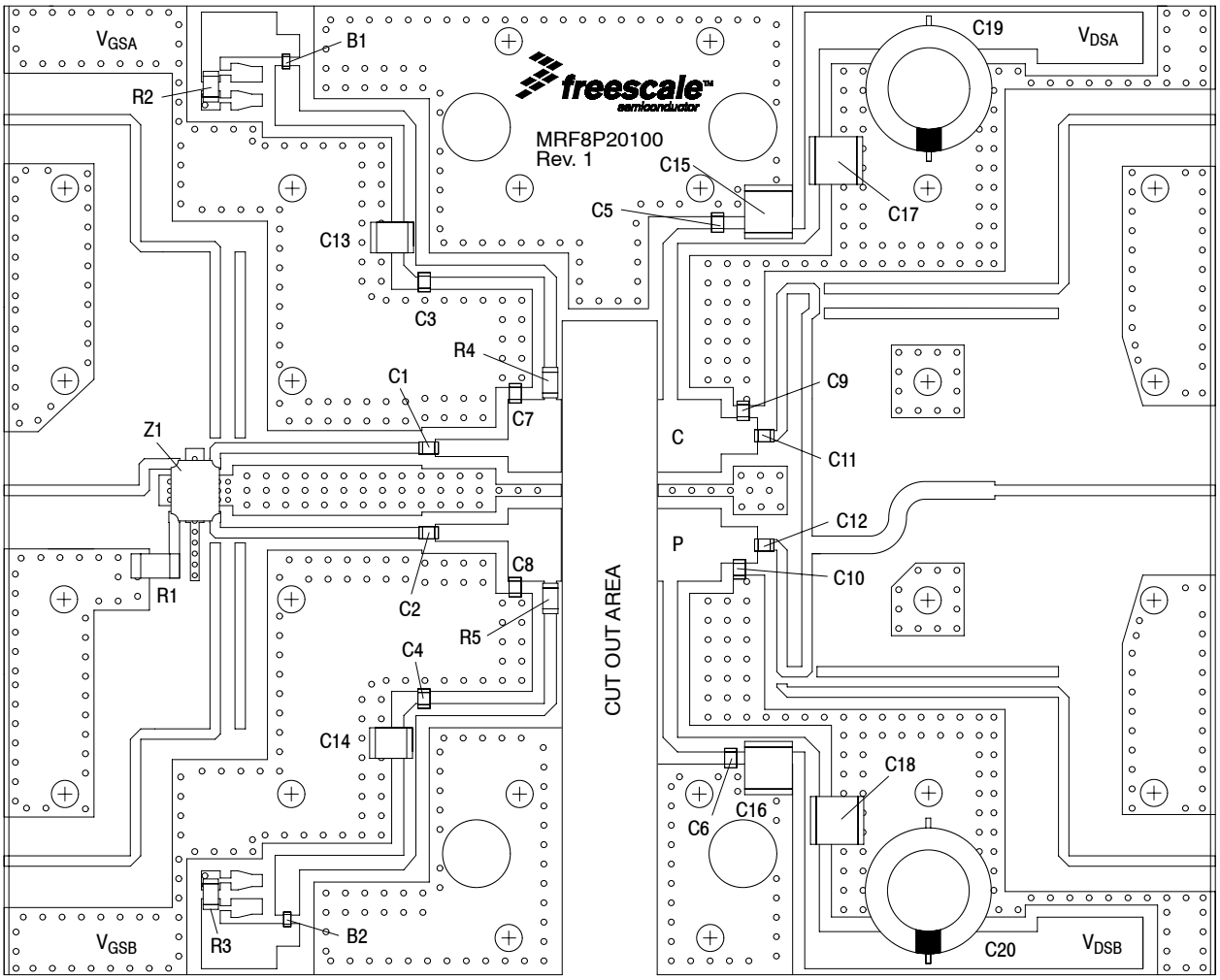


Figure 2. MRF8P20100HR3(HSR3) Test Circuit Component Layout

Table 5. MRF8P20100HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	RF Ferrite Beads	MPZ2012S300AT000	TDK
C1, C2, C3, C4, C5, C6	15 pF Chip Capacitors	ATC600F150JT250XT	ATC
C7, C8	0.3 pF Chip Capacitors	ATC600F0R3BT250XT	ATC
C9, C10	1.2 pF Chip Capacitors	ATC600F1R2BT250XT	ATC
C11, C12	10 pF Chip Capacitors	ATC600F100JT250XT	ATC
C13, C14	4.7 μF, 50 V Chip Capacitors	C4532X5R1H475MT	TDK
C15, C16	10 μF, 50 V Chip Capacitors	C5750X7R1H106KT	TDK
C17, C18	22 μF, 50 V Chip Capacitors	C5750KF1H226ZT	TDK
C19, C20	220 μF, 63 V Electrolytic Capacitors	MCGPR63V227M10X21	Multicomp
R1	50 Ω, 4 W Chip Resistor	ATCCW12010T0050GBK	ATC
R2, R3	10 KΩ, 1/4 W Chip Resistors	CRCW120612R0FKEA	Vishay
R4, R5	12 Ω, 1/4 W Chip Resistors	CRCW120612R0FKEA	Vishay
Z1	1900 MHz Band 90°, 3 dB Chip Hybrid Coupler	1P503S	Anaren
PCB	0.020″, ε_r = 3.5	RO4350B	Rogers

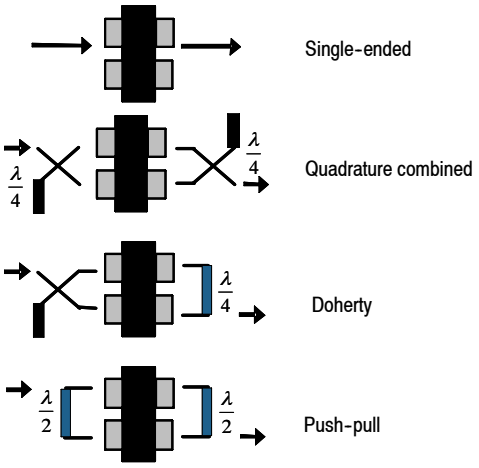


Figure 3. Possible Circuit Topologies

TYPICAL CHARACTERISTICS

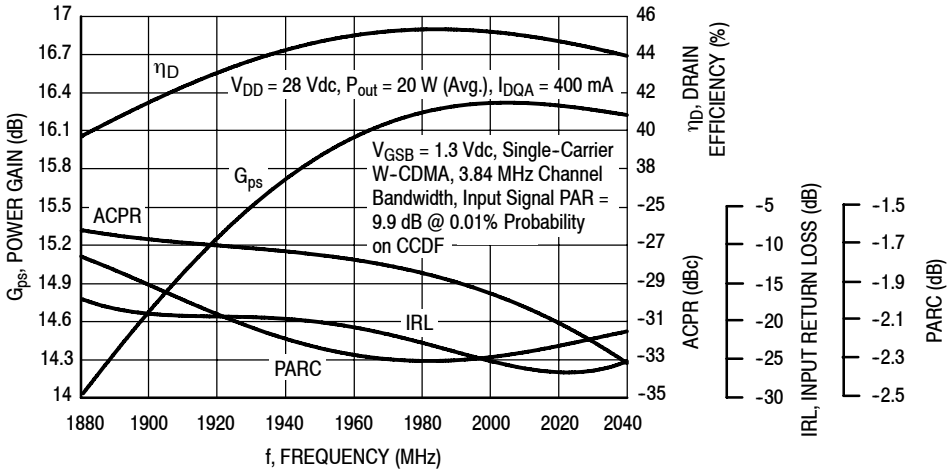


Figure 4. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P_{out} = 20 Watts Avg.

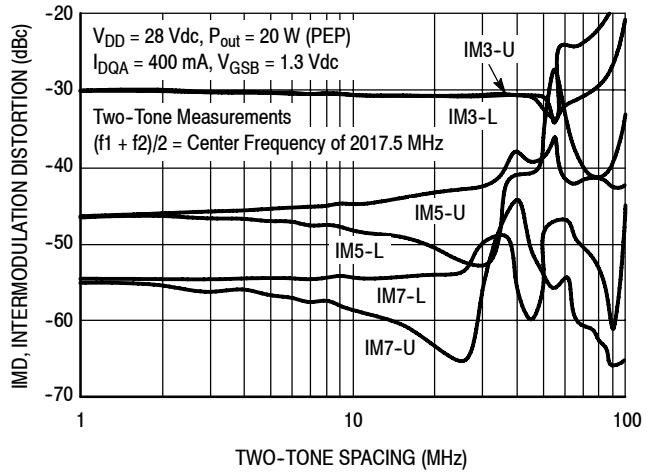


Figure 5. Intermodulation Distortion Products versus Two-Tone Spacing

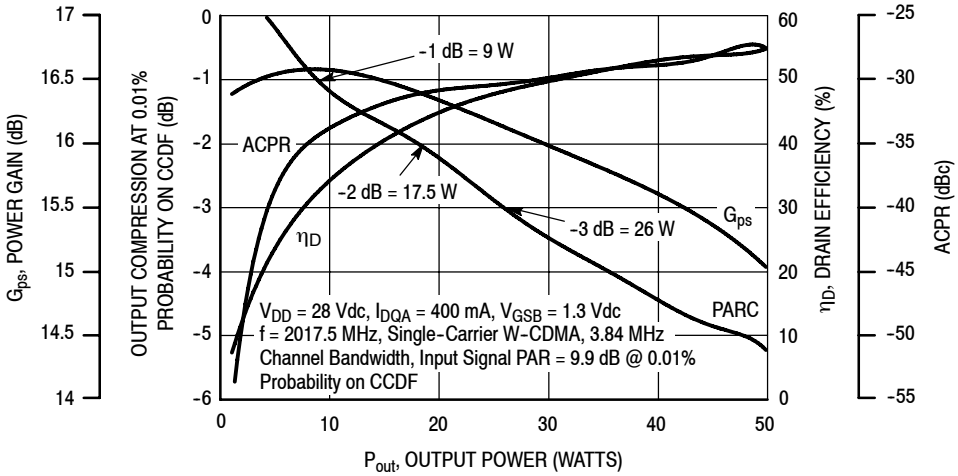


Figure 6. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

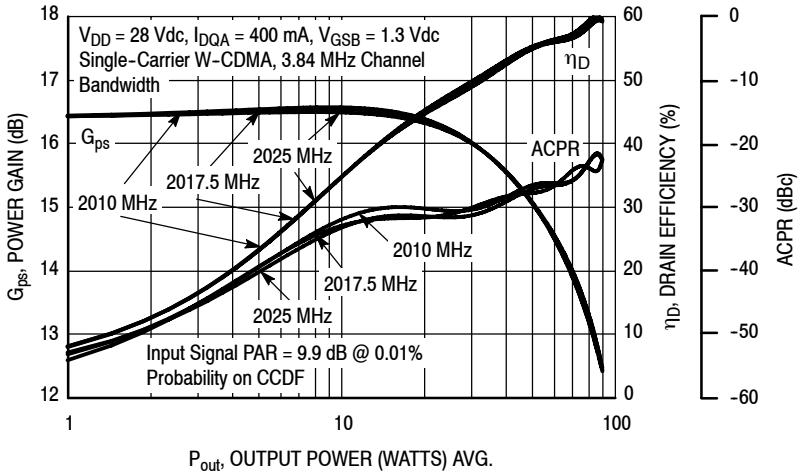


Figure 7. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

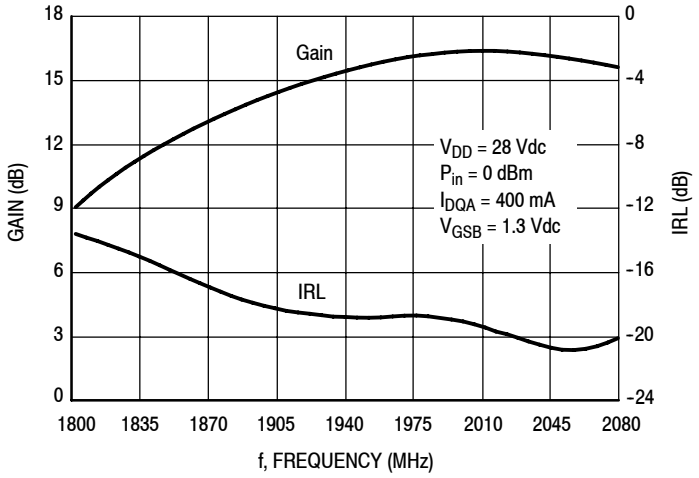


Figure 8. Broadband Frequency Response

W-CDMA TEST SIGNAL

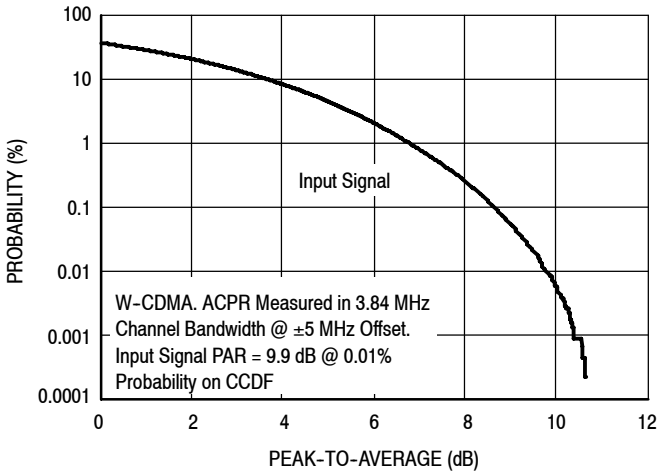


Figure 9. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

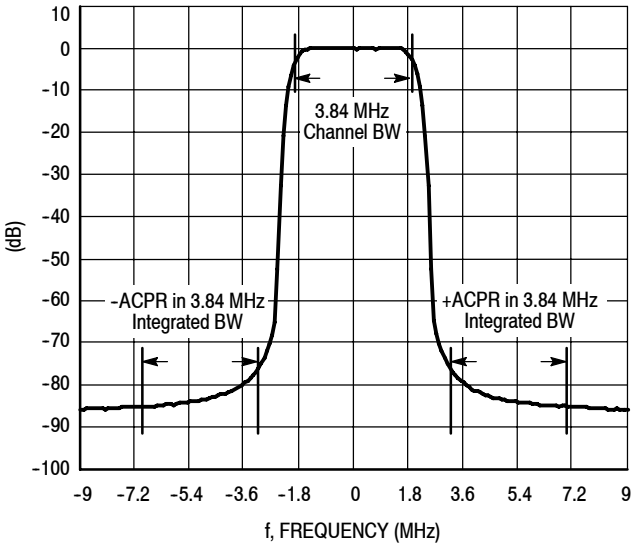


Figure 10. Single-Carrier W-CDMA Spectrum

V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1880	3.23 – j10.1	6.35 – j5.32
1900	3.36 – j9.78	6.64 – j5.29
1920	3.42 – j9.61	6.86 – j5.42
1940	3.33 – j9.44	6.94 – j5.64
1960	3.22 – j9.16	6.99 – j5.82
1980	3.31 – j8.90	7.17 – j6.03
2000	3.48 – j8.87	7.33 – j6.46
2020	3.39 – j8.92	7.10 – j6.92
2040	3.13 – j8.58	6.64 – j6.97

Note: Measured with Peaking side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

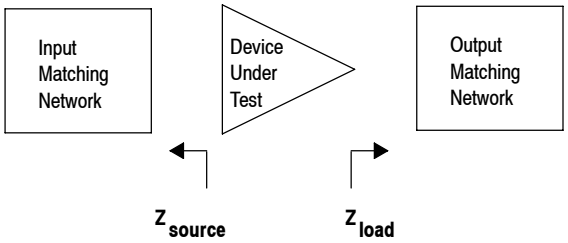


Figure 11. Series Equivalent Source and Load Impedance — Carrier Side

V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1880	3.83 – j10.28	0.67 – j7.03
1900	3.88 – j10.00	0.68 – j6.71
1920	3.82 – j9.81	0.62 – j6.43
1940	3.61 – j9.59	0.48 – j6.11
1960	3.50 – j9.30	0.35 – j5.70
1980	3.58 – j9.10	0.35 – j5.32
2000	3.61 – j9.13	0.35 – j5.07
2020	3.43 – j9.10	0.21 – j4.75
2040	3.10 – j8.55	0.10 – j4.19

Note: Measured with Carrier side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

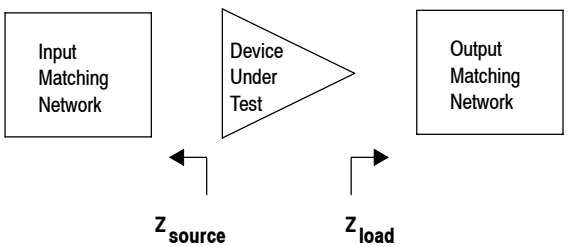
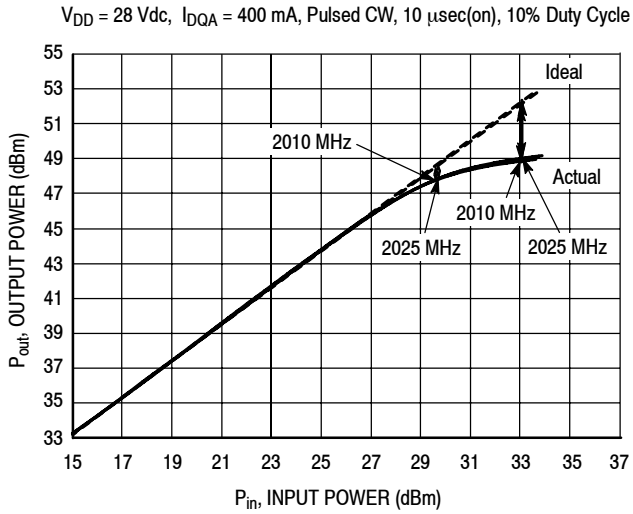


Figure 12. Series Equivalent Source and Load Impedance — Peaking Side

ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

f (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
2010	62	47.9	76	48.8
2025	63	48.0	78	48.9

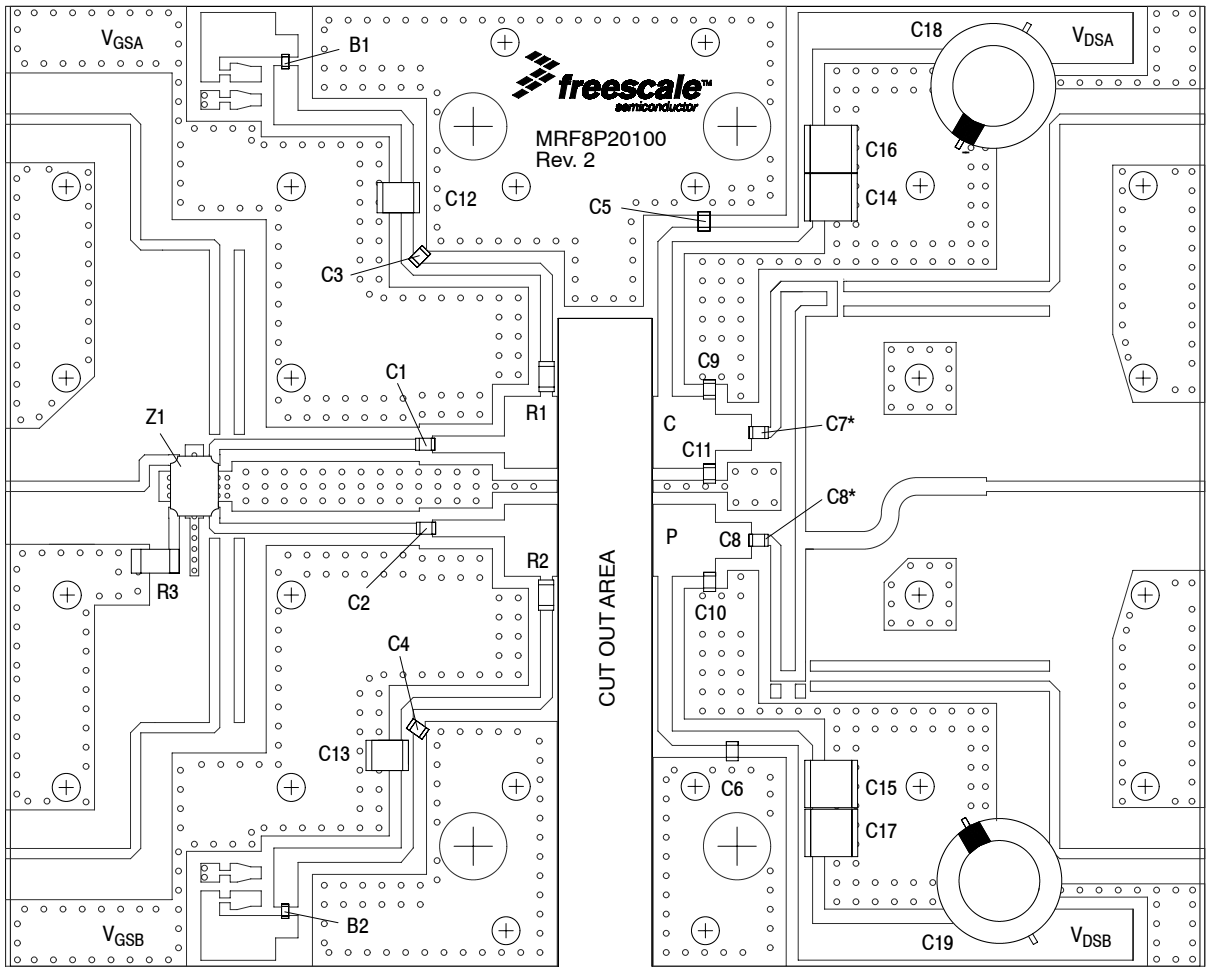
Test Impedances per Compression Level

f (MHz)		Z_{source} Ω	Z_{load} Ω
2010	P1dB	2.83 – j12.46	3.18 – j6.16
2025	P1dB	3.43 – j13.20	3.16 – j6.14

Figure 13. Pulsed CW Output Power versus Input Power @ 28 V

NOTE: Measurement made on the Class AB, carrier side of the device.

ALTERNATE CHARACTERIZATION — 1880 MHz



*C7 and C8 are mounted vertically.

Figure 14. MRF8P20100HR3(HSR3) Test Circuit Component Layout — 1880 MHz

Table 6. MRF8P20100HR3(HSR3) Test Circuit Component Designations and Values — 1880 MHz

Part	Description	Part Number	Manufacturer
B1, B2	RF Ferrite Beads	MPZ2012S300AT000	TDK
C1, C2, C3, C4, C5, C6	12 pF Chip Capacitors	ATC600F120JT250XT	ATC
C7, C8	10 pF Chip Capacitors	ATC600F100JT250XT	ATC
C9, C10, C11	1.5 pF Chip Capacitors	ATC600F1R5BT250XT	ATC
C12, C13	4.7 μF, 50 V Chip Capacitors	C4532X5R1H475MT	TDK
C14, C15	10 μF, 50 V Chip Capacitors	C5750X7R1H106KT	TDK
C16, C17	22 μF, 50 V Chip Capacitors	C5750KF1H226ZT	TDK
C18, C19	220 μF, 63 V Electrolytic Capacitors	MCGPR63V227M10X21	Multicomp
R1, R2	12 Ω, 1/4 W Chip Resistors	CRCW120612R0FKEA	Vishay
R3	50 Ω, 4 W Chip Resistor	CW12010T0050GBK	ATC
Z1	1900 MHz Band 90°, 3 dB Chip Hybrid Coupler	1P503S	Anaren
PCB	0.020″, ε_r = 3.5	RO4350B	Rogers

TYPICAL CHARACTERISTICS — 1880 MHz

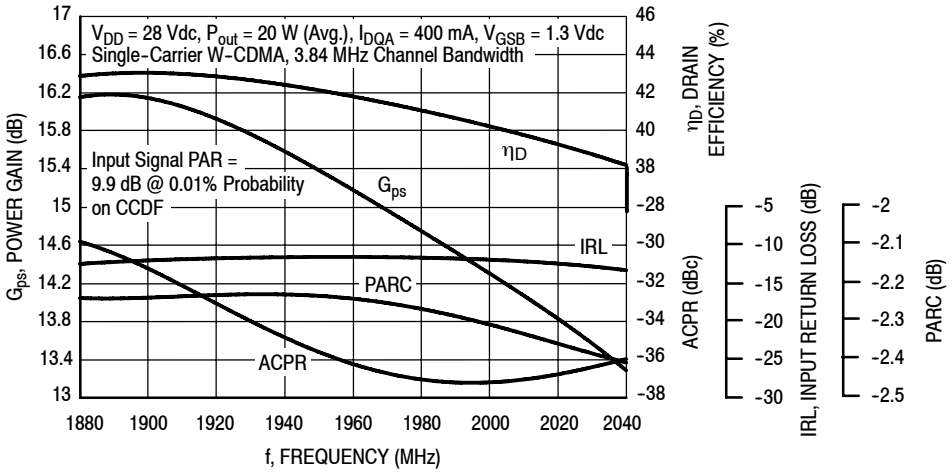


Figure 15. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ P_{out} = 20 Watts Avg.

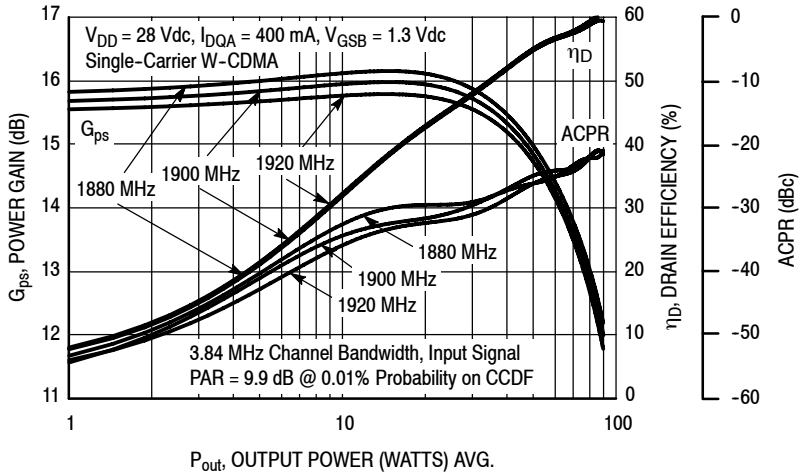


Figure 16. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

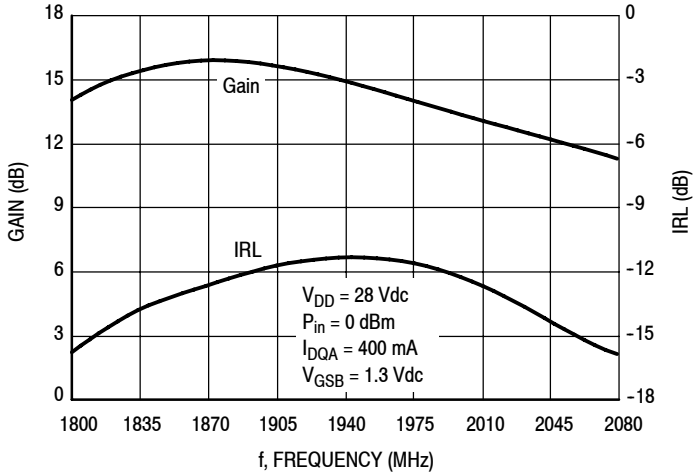


Figure 17. Broadband Frequency Response

V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1880	2.22 – j7.34	6.32 – j6.84
1900	2.27 – j7.04	6.13 – j6.84
1920	2.35 – j6.75	5.91 – j6.87
1940	2.41 – j6.52	5.61 – j6.97
1960	2.40 – j6.33	5.25 – j7.09
1980	2.42 – j6.19	4.95 – j7.22
2000	2.45 – j6.17	4.62 – j7.41
2020	2.34 – j6.19	4.09 – j7.46
2040	2.15 – j5.91	3.56 – j7.08

Note: Measured with Peaking side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

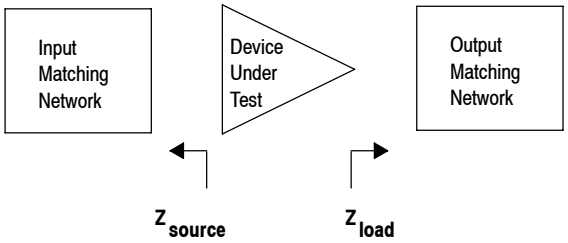


Figure 18. Series Equivalent Source and Load Impedance — Carrier Side — 1880 MHz

V_{DD} = 28 Vdc, I_{DQA} = 400 mA, V_{GSB} = 1.3 Vdc, P_{out} = 20 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1880	2.67 – j6.62	0.50 – j3.80
1900	2.71 – j6.34	0.66 – j3.23
1920	2.76 – j6.11	0.88 – j2.69
1940	2.69 – j5.98	1.10 – j2.22
1960	2.62 – j5.84	1.36 – j1.80
1980	2.58 – j5.76	1.66 – j1.45
2000	2.50 – j5.75	2.03 – j1.17
2020	2.29 – j5.63	2.37 – j0.98
2040	2.11 – j5.23	2.64 – j0.79

Note: Measured with Carrier side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

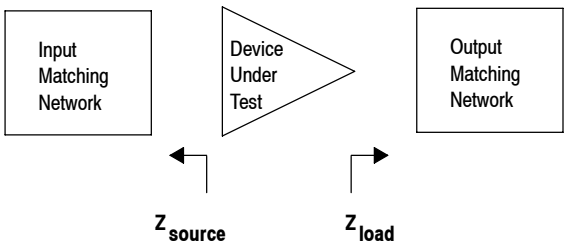


Figure 19. Series Equivalent Source and Load Impedance — Peaking Side — 1880 MHz

ALTERNATE CHARACTERIZATION — GSM EDGE

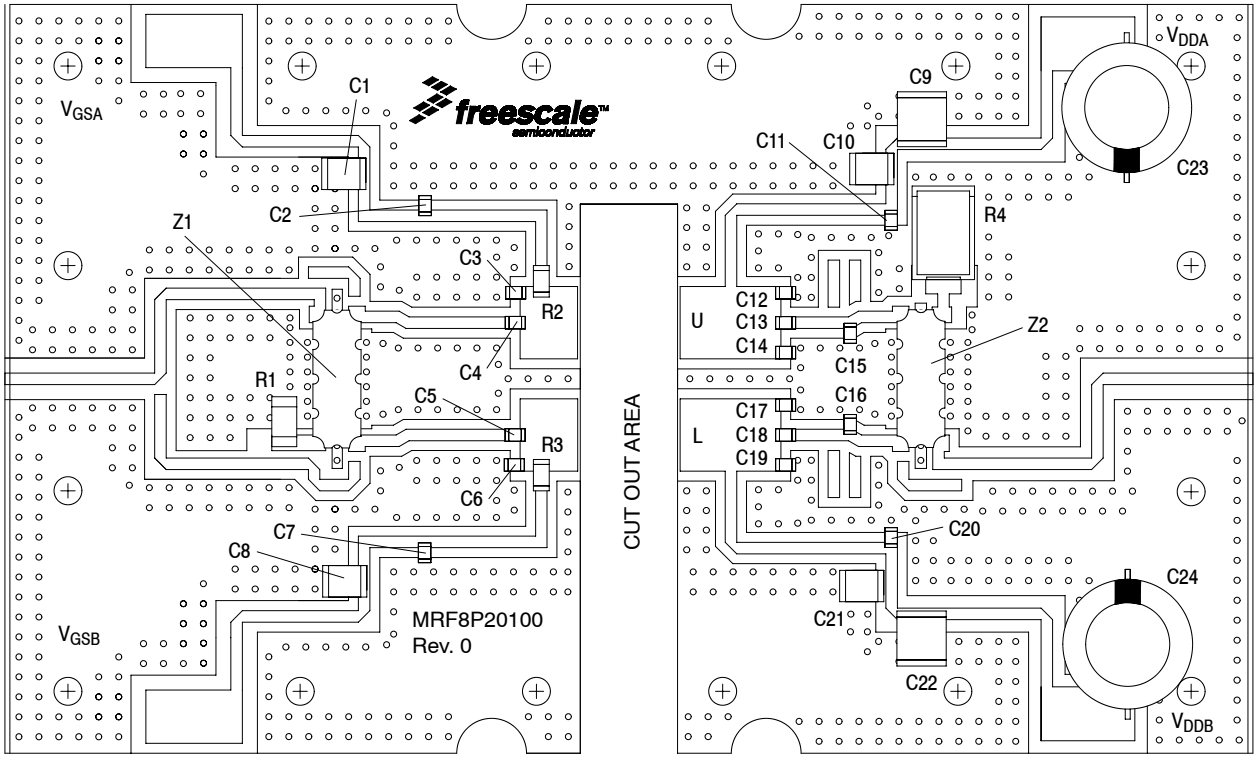


Figure 20. MRF8P20100HR3(HSR3) Test Circuit Component Layout — GSM EDGE

Table 7. MRF8P20100HR3(HSR3) Test Circuit Component Designations and Values — GSM EDGE

Part	Description	Part Number	Manufacturer
C1, C8	2.2 μF, 50 V Chip Capacitors	C3225X7R2A225KT	TDK
C2, C7	12 pF Chip Capacitors	ATC600F120JT250XT	ATC
C3, C6	2.7 pF Chip Capacitors	ATC600F2R7BT250XT	ATC
C4, C5, C11, C20	15 pF Chip Capacitors	ATC600F150JT250XT	ATC
C9, C22	10 μF, 50 V Chip Capacitors	C5750X7R1H106K	TDK
C10, C21	4.7 μF, 50 V Chip Capacitors	C4532X5R1H475M	TDK
C12, C19	0.3 pF Chip Capacitors	ATC600F0R3BT250XT	ATC
C13, C18	22 pF Chip Capacitors	ATC600F220JT250XT	ATC
C14, C17	0.6 pF Chip Capacitors	ATC600F0R6BT250XT	ATC
C15, C16	0.5 pF Chip Capacitors	ATC600F0R5BT250XT	ATC
C23, C24	220 pF, 63 V Electrolytic Capacitors	MCGPR63V227M10X21	Multicomp
R1	50 Ω, 4 W Chip Resistor	CW12010T0050GBK	ATC
R2, R3	12 Ω, 1/4 W Chip Resistors	CRCW120612R0FKEA	Vishay
R4	50 Ω, 80 W, Termination	SMT3725ALNF	EMC
Z1, Z2	1900 MHz Band 90°, 3 dB Chip Hybrid Couplers	XC1900E-03	Anaren
PCB	0.020″, ε_r = 3.5	RO4350B	Rogers

TYPICAL CHARACTERISTICS — GSM EDGE

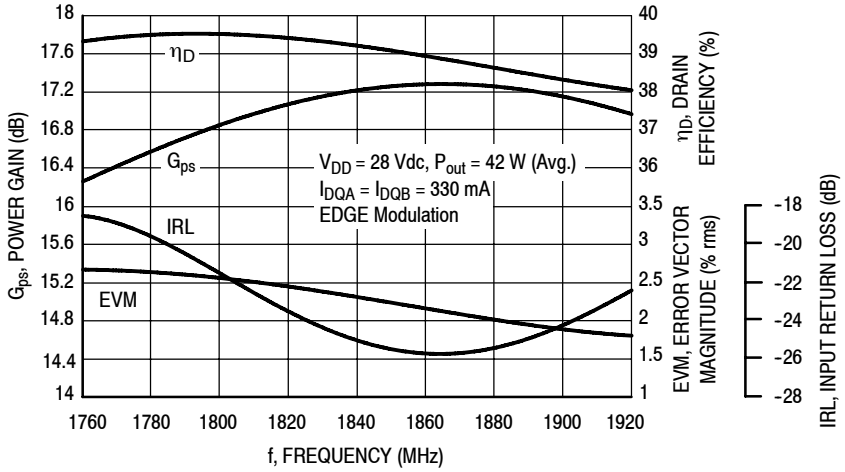


Figure 21. Power Gain, Input Return Loss and Drain Efficiency versus Frequency @ P_{out} = 42 Watts Avg.

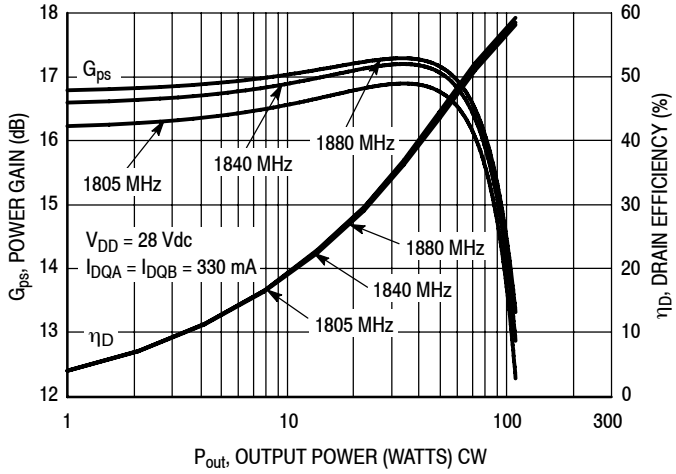


Figure 22. Power Gain and Drain Efficiency versus Output Power

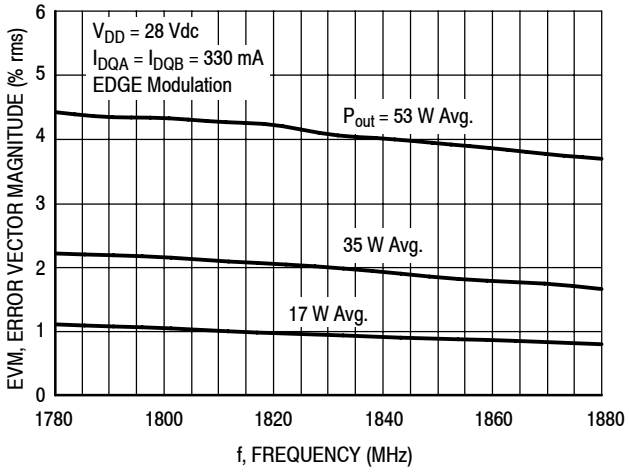


Figure 23. EVM versus Frequency

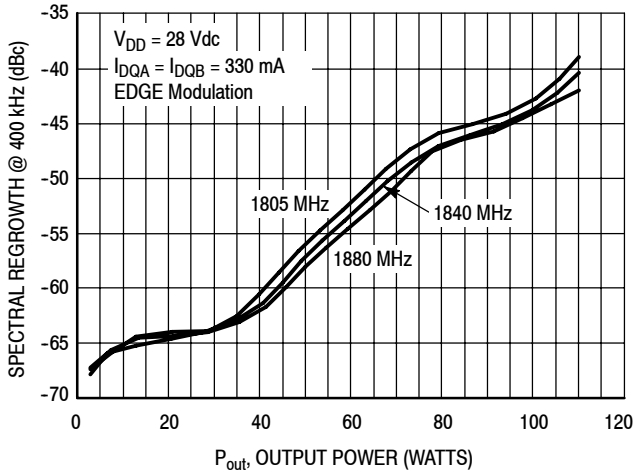


Figure 24. Spectral Regrowth at 400 kHz versus Output Power

TYPICAL CHARACTERISTICS — GSM EDGE

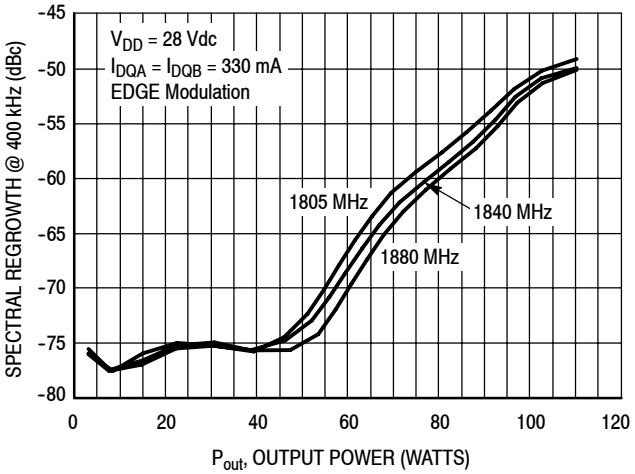


Figure 25. Spectral Regrowth at 600 kHz versus Output Power

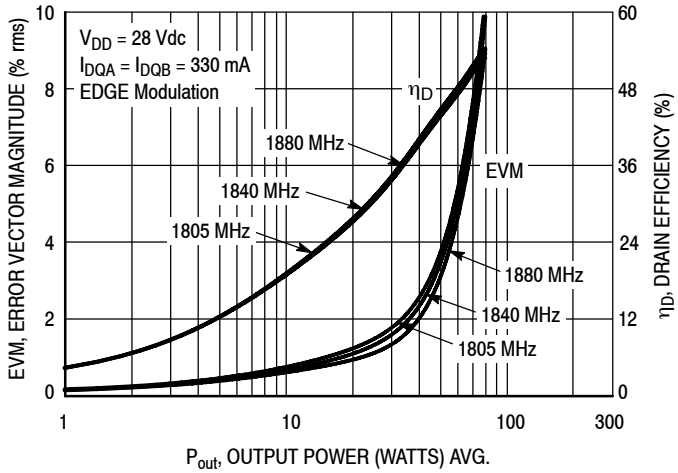


Figure 26. EVM and Drain Efficiency versus Output Power

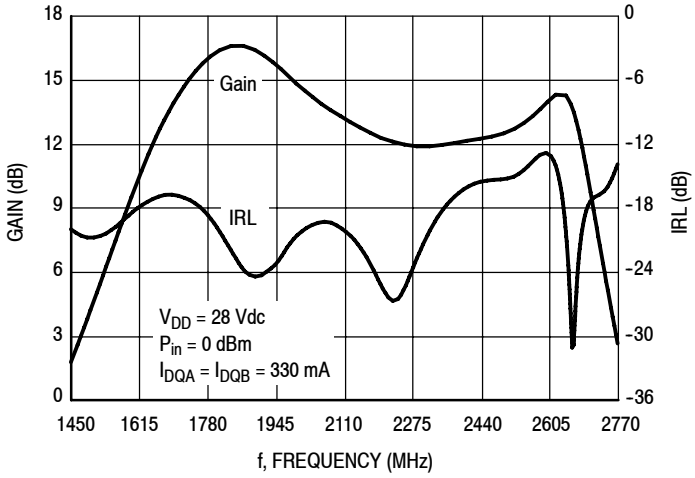


Figure 27. Broadband Frequency Response

V_{DD} = 28 Vdc, I_{DQA} = I_{DQB} = 330 mA, P_{out} = 42 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1760	3.12 – j7.74	4.39 – j7.66
1780	3.13 – j7.35	4.44 – j7.38
1800	3.21 – j7.12	4.50 – j7.30
1820	3.20 – j7.05	4.42 – j7.31
1840	3.08 – j6.98	4.26 – j7.28
1860	2.95 – j6.82	4.10 – j7.15
1880	2.88 – j6.57	4.00 – j6.92
1900	2.87 – j6.21	3.95 – j6.62
1920	2.89 – j5.85	3.94 – j6.36

Note: Measured with Lower side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

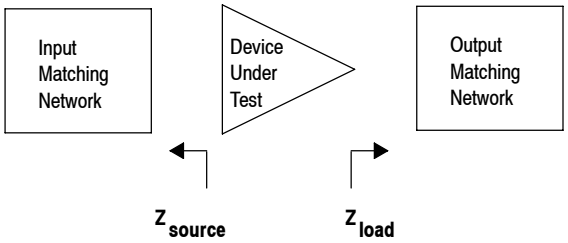


Figure 28. Series Equivalent Source and Load Impedance — Upper Side — GSM EDGE

V_{DD} = 28 Vdc, I_{DQA} = I_{DQB} = 330 Vdc, P_{out} = 42 W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
1760	3.72 – j7.89	3.55 – j5.43
1780	3.77 – j7.60	3.62 – j5.09
1800	3.82 – j7.48	3.76 – j4.85
1820	3.72 – j7.46	3.87 – j4.75
1840	3.55 – j7.37	3.90 – j4.66
1860	3.39 – j7.16	3.92 – j4.52
1880	3.29 – j6.85	3.96 – j4.31
1900	3.24 – j6.48	4.03 – j4.02
1920	3.22 – j6.17	4.13 – j3.71

Note: Measured with Upper side open.

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

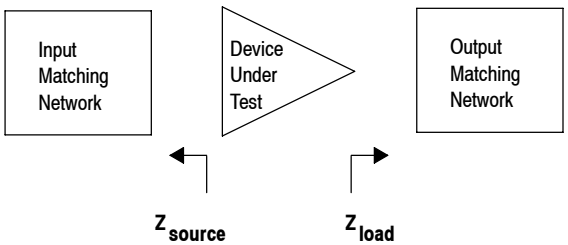
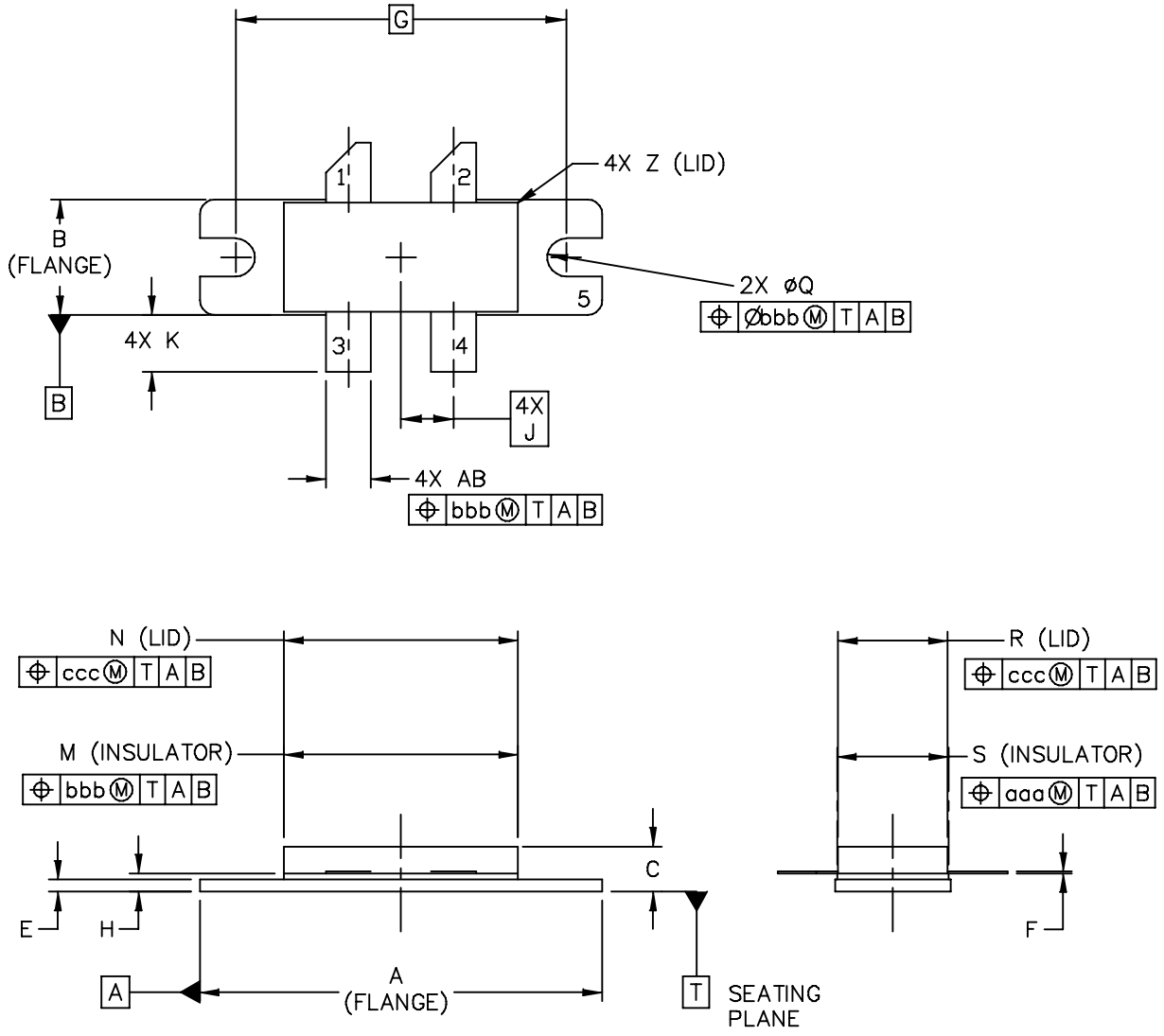


Figure 29. Series Equivalent Source and Load Impedance — Lower Side — GSM EDGE

PACKAGE DIMENSIONS



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3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	1.335	1.345	33.91	34.16	R	.365	.375	9.27	9.53
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.52
C	.125	.170	3.18	4.32	U		.040		1.02
E	.035	.045	0.89	1.14	Z		.030		0.76
F	.003	.006	0.08	0.15	AB	.145	.155	3.68	3.94
G	1.100 BSC		27.94 BSC						
H	.057	.067	1.45	1.7	aaa		.005		0.127
J	.175 BSC		4.44 BSC		bbb		.010		0.254
K	.170	.210	4.32	5.33	ccc		.015		0.381
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
Q	ø.118	ø.138	ø3	ø3.51					

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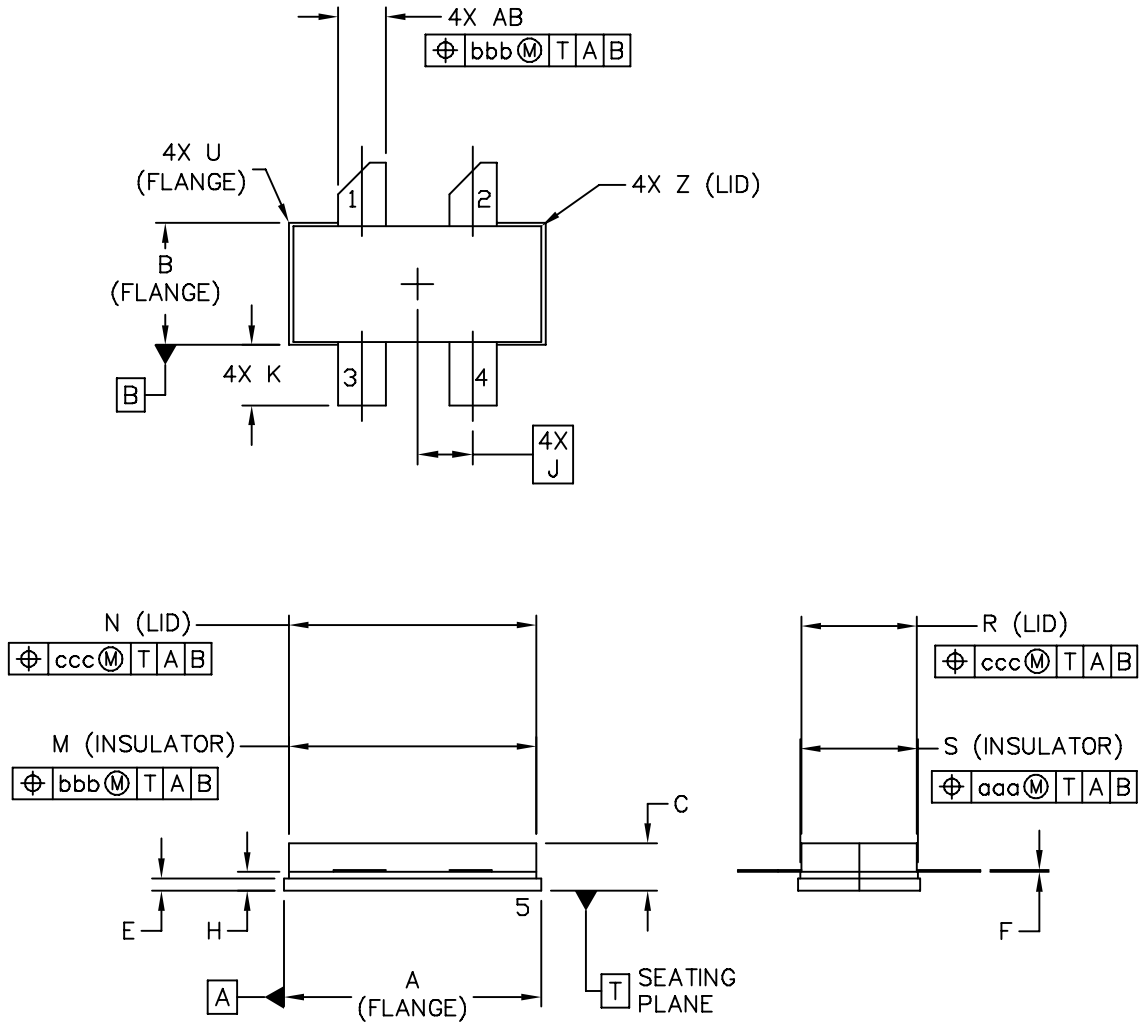
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STYLE 1:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX	DIM	INCH MIN	INCH MAX	MILLIMETER MIN	MILLIMETER MAX
A	.805	.815	20.45	20.7	U		.040		1.02
B	.380	.390	9.65	9.91	Z		.030		0.76
C	.125	.170	3.18	4.32	AB	.145	.155	3.68	3.94
E	.035	.045	0.89	1.14					
F	.003	.006	0.08	0.15	aaa		.005		0.127
H	.057	.067	1.45	1.7	bbb		.010		0.254
J	.175 BSC		4.44 BSC		ccc		.015		0.381
K	.170	.210	4.32	5.33					
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.52					

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PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Refer to the following documents, tools and software to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at http://www.freescale.com, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Apr. 2010	• Initial Release of Data Sheet

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